

UNISONIC TECHNOLOGIES CO., LTD

30NM70 Power MOSFET

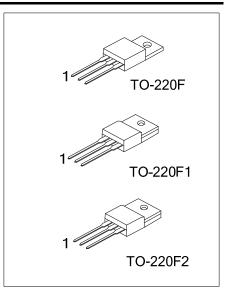
30A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

■ DESCRIPTION

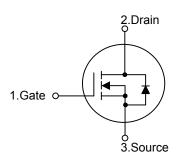
The **UTC 30NM70** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

■ FEATURES

- * $R_{DS(ON)}$ < 170 m Ω @ V_{GS} = 10V, I_D = 15A
- * High Switching Speed
- * 100% Avalanche Tested



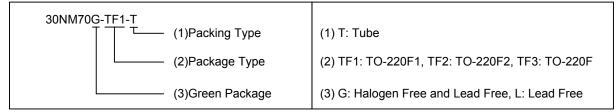
■ SYMBOL



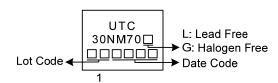
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
30NM70L-TF1-T	30NM70G-TF1-T	TO-220F1	G	D	S	Tube	
30NM70L-TF2-T	30NM70G-TF2-T	TO-220F2	G	D	S	Tube	
30NM70L-TF3-T	30NM70G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	700	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous	I_{D}	30	Α	
	Pulsed (Note 2)	I_{DM}	120	Α	
Avalanche Current (Note 2)		I_{AR}	5.86	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	1116	mJ	
Peak Diode Recovery dv/dt		dv/dt	16.5	V/ns	
Power Dissipation		P_D	34	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T_{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L =65mH, I_{AS} = 5.86A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 30A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	$\theta_{ m JC}$	0.96	°C/W	

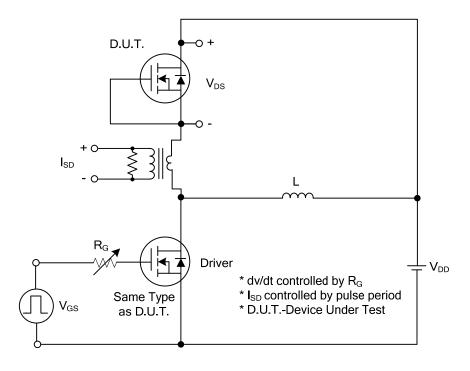
■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	700			V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =700V, V _{GS} =0V			50	μA	
Gate- Source Leakage Current	Forward	ı	V _{GS} =+30V, V _{DS} =0V			+100	nA	
	Reverse	I_{GSS}	V _{GS} =-30V, V _{DS} =0V			-100	nA	
ON CHARACTERISTICS						_		
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.5		4.5	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =15A			170	mΩ	
DYNAMIC PARAMETERS	_							
nput Capacitance		C _{ISS}			2400		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		1900		pF	
Reverse Transfer Capacitance		C _{RSS}			125		pF	
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)		Q_G	V _{DS} =100V, V _{GS} =10V, I _D =30A,		88		nC	
Gate to Source Charge		Q_{GS}	I_{G} =100V, V_{GS} =10V, I_{D} =30A, I_{G} =10mA (Note 1,2)		20		nC	
Gate to Drain Charge		Q_GD	IG-TOTIA (Note 1,2)		36		nC	
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			38		ns	
Rise Time		t_R	V_{DD} =100V, V_{GS} =10V I_{D} =30A,		40		ns	
Turn-OFF Delay Time		$t_{D(OFF)}$	$R_G=25\Omega$, (Note 1,2)		230		ns	
Fall-Time		t_{F}			100		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				30	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				120	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =30A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =30A, V _{GS} =0V,		610		ns	
Body Diode Reverse Recovery C	harge	Q_{rr}	dI _F /dt=100A/μs		12.3		μC	

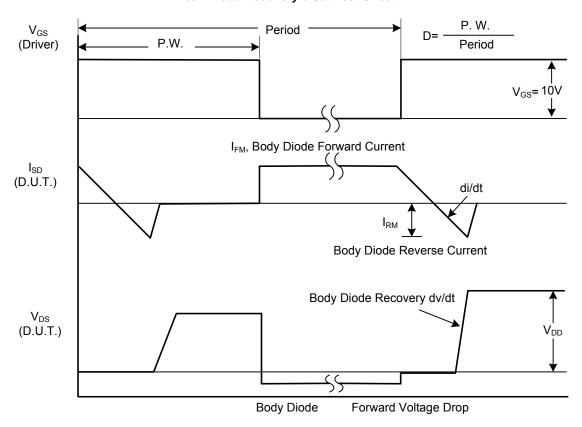
Notes: 1. Pulse Test : Pulse width \leq 300 μ s, Duty cycle \leq 2%.

2. Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS



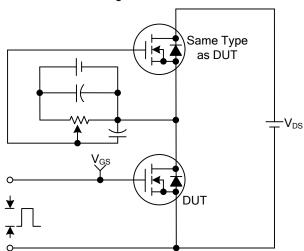
Peak Diode Recovery dv/dt Test Circuit



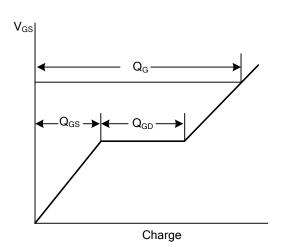
Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)

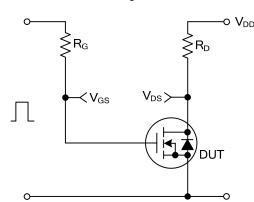
Gate Charge Test Circuit



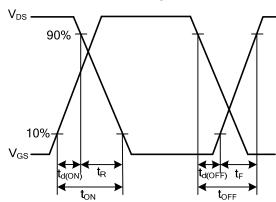
Gate Charge Waveforms



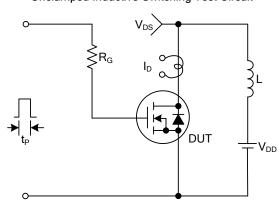
Resistive Switching Test Circuit



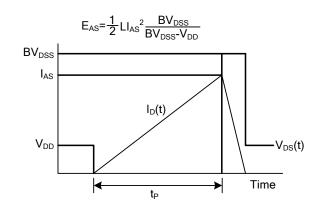
Resistive Switching Waveforms



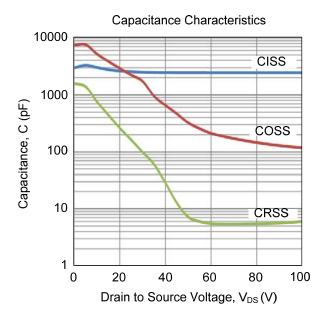
Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms



■ TYPICAL CHARACTERISTICS



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